

74LVQ32 Low Voltage Quad 2-Input OR Gate

General Description

The LVQ32 contains four 2-input OR gates.

Features

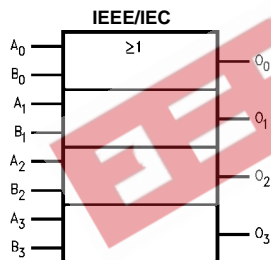
- Ideal for low power/low noise 3.3V applications
- Guaranteed simultaneous switching noise level and dynamic threshold performance
- Guaranteed pin-to-pin skew AC performance
- Guaranteed incident wave switching into 75Ω

Ordering Code:

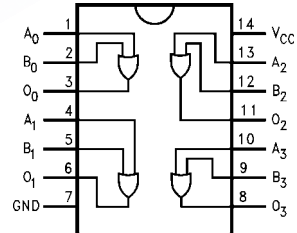
Order Number	Package Number	Package Description
74LVQ32SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
74LVQ32SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbol



Connection Diagram



Pin Descriptions

Pin Names	Description
A_n, B_n	Inputs
O_n	Outputs

Absolute Maximum Ratings (Note 1)		Recommended Operating Conditions (Note 2)	
Supply Voltage (V_{CC})	-0.5V to +7.0V	Supply Voltage (V_{CC})	LVQ 2.0V to 3.6V
DC Input Diode Current (I_{IK})		Input Voltage (V_I)	0V to V_{CC}
$V_I = -0.5V$	-20 mA	Output Voltage (V_O)	0V to V_{CC}
$V_I = V_{CC} + 0.5V$	+20 mA	Operating Temperature (T_A)	74LVQ -40°C to +85°C
DC Input Voltage (V_I)	-0.5V to $V_{CC} + 0.5V$	Minimum Input Edge Rate ($\Delta V/\Delta t$)	V_{IN} from 0.8V to 2.0V
DC Output Diode Current (I_{OK})		V_{CC} @ 3.0V	125 mV/ns
$V_O = -0.5V$	-20 mA	Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.	
$V_O = V_{CC} + 0.5V$	+20 mA	Note 2: Unused inputs must be held HIGH or LOW. They may not float.	
DC Output Voltage (V_O)	-0.5V to $V_{CC} + 0.5V$		
DC Output Source or Sink Current (I_O)	± 50 mA		
DC V_{CC} or Ground Current (I_{CC} or I_{GND})	± 200 mA		
Storage Temperature (T_{STG})	-65°C to +150°C		
DC Latch-Up Source or Sink Current	± 100 mA		

DC Electrical Characteristics

Symbol	Parameter	V_{CC} (V)	$T_A = +25^\circ C$		$T_A = -40^\circ C$ to $+85^\circ C$		Units	Conditions
			Typ	Guaranteed Limits	Guaranteed Limits	Guaranteed Limits		
V_{IH}	Minimum High Level Input Voltage	3.0	1.5	2.0	2.0	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$	
V_{IL}	Maximum Low Level Input Voltage	3.0	1.5	0.8	0.8	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$	
V_{OH}	Minimum High Level Output Voltage	3.0	2.99	2.9	2.9	V	$I_{OUT} = -50 \mu A$	
		3.0		2.58	2.48	V	$V_{IN} = V_{IL}$ or V_{IH} (Note 3) $I_{OH} = -12$ mA	
V_{OL}	Maximum Low Level Output Voltage	3.0	0.002	0.1	0.1	V	$I_{OUT} = 50 \mu A$	
		3.0		0.36	0.44	V	$V_{IN} = V_{IL}$ or V_{IH} (Note 3) $I_{OL} = 12$ mA	
I_{IN}	Maximum Input Leakage Current	3.6		± 0.1	± 1.0	μA	$V_I = V_{CC}$, GND	
I_{OLD}	Minimum Dynamic Output Current (Note 4)	3.6			36	mA	$V_{OLD} = 0.8V$ Max (Note 5)	
I_{OHD}	Output Current (Note 4)	3.6			-25	mA	$V_{OHD} = 2.0V$ Min (Note 5)	
I_{CC}	Maximum Quiescent Supply Current	3.6		2.0	20.0	μA	$V_{IN} = V_{CC}$ or GND	
V_{OLP}	Quiet Output Maximum Dynamic V_{OL}	3.3	0.5	0.8		V	(Note 6)(Note 7)	
V_{OLV}	Quiet Output Minimum Dynamic V_{OL}	3.3	-0.5	-0.8		V	(Note 6)(Note 7)	
V_{IHD}	Maximum High Level Dynamic Input Voltage	3.3	1.9	2.0		V	(Note 6)(Note 8)	
V_{ILD}	Maximum Low Level Dynamic Input Voltage	3.3	1.8	0.8		V	(Note 6)(Note 8)	

Note 3: All outputs loaded; thresholds on input associated with output under test.

Note 4: Maximum test duration 2.0 ms, one output loaded at a time.

Note 5: Incident wave switching on transmission lines with impedances as low as 75 Ω for commercial temperature range is guaranteed for 74LVQ.

Note 6: Worst case package.

Note 7: Max number of outputs defined as (n). Data inputs are driven 0V to 3.3V; one output at GND.

Note 8: Max number of Data Inputs (n) switching. (n - 1) inputs switching 0V to 3.3V. Input-under-test switching: 3.3V to threshold (V_{ILD}), 0V to threshold (V_{IHD}), $f = 1$ MHz.

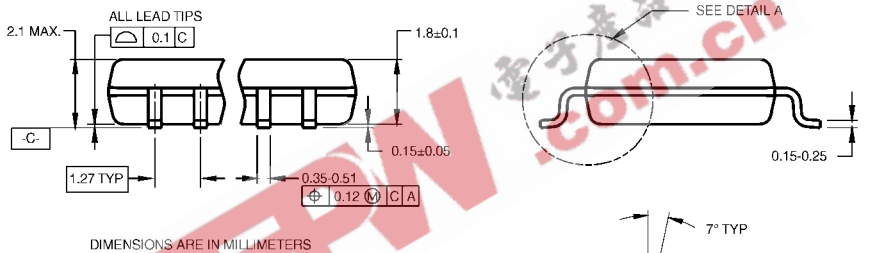
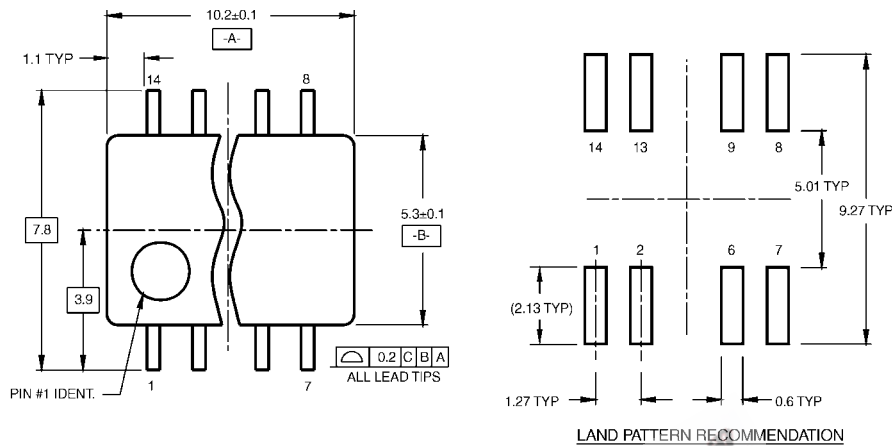
AC Electrical Characteristics								
Symbol	Parameter	V _{CC} (V)	T _A = +25°C C _L = 50 pF			T _A = -40°C to +85°C C _L = 50 pF		Units
			Min	Typ	Max	Min	Max	
t _{PLH}	Propagation Delay	2.7 3.3 ± 0.3	1.5 1.5	8.4 7.0	12.7 9.0	1.5 1.5	14.0 10.0	ns
t _{PHL}	Propagation Delay	2.7 3.3 ± 0.3	1.5 1.5	8.4 7.0	12.0 8.5	1.0 1.5	13.0 9.0	ns
t _{OSSL} t _{OSLH}	Output to Output Skew (Note 9)	2.7 3.3 ± 0.3		1.0 1.0	1.5 1.5		1.5 1.5	ns
<p>Note 9: Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t_{OSSL}) or LOW-to-HIGH (t_{OSLH}). Parameter guaranteed by design.</p>								
Capacitance								
Symbol	Parameter	Typ	Units	Conditions				
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = Open				
C _{PD} (Note 10)	Power Dissipation Capacitance	17	pF	V _{CC} = 3.3V				
<p>Note 10: C_{PD} is measured at 10 MHz.</p>								

Physical Dimensions inches (millimeters) unless otherwise noted



14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
Package Number M14A

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



DIMENSIONS ARE IN MILLIMETERS

- NOTES:
- A. CONFORMS TO EIAJ EDR-7320 REGISTRATION, ESTABLISHED IN DECEMBER, 1998.
 - B. DIMENSIONS ARE IN MILLIMETERS.
 - C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.

M14DRevB1

14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide Package Number M14D

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